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Application/Control No.	Applicant(s)/Patent under Reexamination	
10/083,359	KAGEYAMA ET AL.	
Examiner	Art Unit	

John Van Bramer

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Class	Subclass	Date	Examiner
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EAST: US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB viewer same (select or selection) same advertising	5/15/2007	JVB
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